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Optical nonlinearity enhancement of graded metal-dielectric composite films

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Abstract

We have derived the local electric field inside graded metal-dielectric composite films with weak nonlinearity analytically, which further yields the effective linear dielectric constant and third-order nonlinear susceptibility of the graded structures. As a result, the composition-dependent gradation can produce a broad resonant plasmon band in the optical region, resulting in a large enhancement of the optical nonlinearity and hence a large figure of merit.

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In contrast to bulk materials, the corresponding thin films often possess different optical properties [1,2]. It is also known that graded materials [3,4] have quite different physical properties from the homogeneous materials [5]. To one's interest, one found that the graded thin films may have better dielectric properties than a single-layer film [6]. However, the traditional theories [7,8] fail to deal with the composites of graded particles. For this purpose, we put forth a first-principles approach [9,10] and a differential effective dipole approximation [11]. The situation becomes more complicated by the presence of nonlinearity which exists in real composites [12–22]. Moreover, there is a great need for nonlinear optical materials with large nonlinear susceptibility or optimal figure of merit (FOM). Therefore, much work has been done on how to gain a large nonlinearity enhancement or optimal FOM of bulk composites by the surface-plasmon resonance in metal-dielectric composites [19], as well as by taking into account the structural information [23,24]. Recently, a large nonlinearity enhancement was found for a sub-wavelength multilayer of titanium dioxide and conjugated polymer [25].

However, the surface plasmon resonant nonlinearity enhancement often occurs concomitantly with a strong absorption, and unfortunately this behavior renders the FOM of the resonant enhancement peak to be too small to be useful. To circumvent this problem, we shall consider a kind of graded metal-dielectric composite film, in which a dielectric component is introduced as spherical particles embedded in the metallic component.

Let us start by considering a graded film with width L. Here the gradation of interest is in the direction perpendicular to the film. In this connection, the local constitutive relation between the displacement D and electric field E is given by

$$D(z;\omega) = \varepsilon(z;\omega)E(z;\omega) + \chi(z;\omega)|E(z;\omega)|^2 E(z;\omega); \tag{1}$$

where $\varepsilon(z;\omega)$ and $\chi(z;\omega)$ are respectively the linear dielectric constant and third-order nonlinear susceptibility of a certain layer inside the graded film. It is worth noting that both $\varepsilon(z;\omega)$ and $\chi(z;\omega)$ are gradation profiles as a function of position z. In view of the metal-dielectric composite layer, $\varepsilon(z;\omega)$ is given by the well-known Maxwell-Garnett approximation

$$\frac{(z;\omega) \quad {}_1(\omega)}{(z;\omega) + 2{}_1(\omega)} = p(z)\frac{{}_2 \quad {}_1(\omega)}{{}_2 + 2{}_1(\omega)}; \tag{2}$$

where ${}_2$ stands for the dielectric constant of the dielectric, and $p(z)$ the layer dielectric profile. It is worth noting that Eq. (2) gives an approximate $(z;\omega)$ for the present geometry. Here the dielectric function of the metal ${}_1(\omega)$ is given by the Drude expression

$${}_1(\omega) = 1 \quad \frac{\omega_p^2}{\omega(\omega + i)}; \tag{3}$$

where ω_p denotes the bulk plasmon frequency, and the collision frequency. Regarding Eq. (2), we should remark more. In fact, it is not possible to calculate $(z;\omega)$ exactly in terms of the layer dielectric profile $p(z)$. However, to obtain an estimate of $(z;\omega)$; we can take a small volume element inside the layer, at a position z. Further, this small volume element can be seen as a composite where the dielectric particles are randomly embedded in the metallic component. Accordingly, the volume fraction of the dielectric particles is $p(z)$. In this regard, the Maxwell-Garnett approximation [namely, Eq. (2)] holds well for computing $(z;\omega)$.

Let us further assume that the weak nonlinearity condition is satisfied in the present work. That is, the contribution of the second term (nonlinear part $(z;\omega)|E(z;\omega)|^2$) in the right-hand side of Eq. (1) is much less than that of the first term (linear part $(z;\omega)$) [12]. Next, we focus on the quasi-static approximation, under which the whole graded structure can be regarded as an effective homogeneous one with effective (overall) linear dielectric constant (ω) and effective (overall) third-order nonlinear susceptibility (ω): In the mathematical expression, the definition of (ω) and (ω) is given by [12]

$$\langle D \rangle = (\omega)E_0 + (\omega)|E_0|^2 E_0; \tag{4}$$

where $\langle \quad \rangle$ stands for the spatial average of , $_0$ and $\mathbf{E}_0 \hat{e}_z$ the applied field along z axis.

Owing to the simple graded structure, we can use the equivalent capacitance of series combination to calculate the linear response (i.e., optical absorption for the metallic film),

$$\frac{1}{(\omega)} = \frac{1}{L}\int_0^L \frac{dz}{(z;\omega)}. \tag{5}$$

For calculating the nonlinear optical response, we first calculate local electric field $E(z;\omega)$ by the identity

$$(z;\omega)E(z;\omega) = (\omega)E_0 \tag{6}$$

due to the virtue of the continuity of the electric displacement. In view of the existence of nonlinearity inside the graded film, the effective nonlinear response (ω) can be given by [12]

$$(\omega)E_0^4 = \langle (z;\omega)|E_{lin}(z)|^2 E_{lin}(z)^2\rangle, \tag{7}$$

where E_{lin} denotes the linear local electric field. We can take one step forward to express the effective nonlinear response as an integral over the film,

$$(\omega) = \frac{1}{L}\int_0^L dz\ (z;\omega)\ \frac{(\omega)}{(z;\omega)}^2\ \frac{(\omega)}{(z;\omega)}^{*2}. \tag{8}$$

In fact, the assumption of a z-dependent Maxwell-Garnett type dielectric profile is equivalent to assume that the local field depends on z only, see Eq. (2). However, the real (ω) should involve an integral over x, y, and z of the local $(x;y;z;\omega)$ multiplied by terms involving $(x;y;z;\omega)$. Thus, Eq. (8) offers an approximate (ω), as expected.

In what follows, we shall do some numerical calculations. First, set $(z;\omega)$ to be a constant $_1$. By doing so, the two components are assumed to have the same real and positive frequency-independent $_1$, so that we could emphasize the enhancement of the optical nonlinearity. Regarding the layer dielectric profile, let us take a power former $p(z) = az^m$. Without loss of generality, the layer width L is taken to be 1.

In Fig. 1, we display (a) the optical absorption $\mathrm{Im}[(\omega)]$; (b) the modulus of the effective third-order optical nonlinearity enhancement $|(\omega)|/_1$; and (c) the FOM $|(\omega)|/\{_1\mathrm{Im}[(\omega)]\}$ as a function of the incident angular frequency ω. Here $\mathrm{Im}[\ ]$ means the imaginary part of . To one's interest, when the layer dielectric profile $p(z)$ is taken

into account, a broad resonant plasmon band is observed always. In other words, the broad band is caused to appear by the effect of the positional dependence of the dielectric or metal. Also, we find that increasing a causes the resonant band not only to be enhanced, but also red-shifted (namely, located at a lower frequency region). In this work a should satisfy $0 < a < 1$, in order to ensure a $p(z)$ which is always smaller than unity. In a word, although the enhancement of the effective third-order optical nonlinearity is often accompanied with the appearance of the optical absorption, the FOM is still possible to be very attractive due to the presence of the positional dependence of the dielectric or metallic components. Moreover, it is worth noting that a prominent surface plasmon resonant peak appears at somewhat higher frequencies in addition to the surface plasmon band. As a increases, this peak is blue-shifted (i.e., locates at a higher frequency region) accordingly.

Similarly, Figure 2 displays the influence of m: It is apparent to see that the broad resonant plasmon band can be enhanced significantly by adjusting m. However, no distinct red-shift occurs for the plasmon band as m varies. In contrast, we notice that increasing m can make the surface plasmon resonant peak red-shifted.

As a matter of fact, the present results do not depend crucially on the particular form of the layer dielectric profile $p(z)$. The only requirement is that we must have a composition-dependent layer to yield a broad plasmon band for the graded film. It should be remarked that the optical response of the graded structure depends on polarization of the incident light, because the incident optical field can always be resolved into two polarizations. However, a large nonlinearity enhancement occurs only when the electric field is parallel to the direction of the gradient [25], and the other polarization does not produce nonlinearity enhancement at all [25]. Fortunately, the nonlinear susceptibilities of both the parallel and perpendicular polarizations are related to the nonlinear phase shift, which can be measured by using the z-scan method [25]. It is of interest to extend our consideration to composites in which graded spherical particles are embedded in a host medium [26] to account for mutual interactions among graded particles [24].

To calculate $(z;!)$; we used Eq. (2) in which metal (or dielectric) serves as a host (or

inclusion). Inversely, we could see metal (or dielectric) as an inclusion (or host), and use the same form as Eq. (2) by exchanging $_1(!)$ and $_2$, and $p(z)$ and $1 \quad p(z)$. In case of $_1(!) > \ _2$, the former always gives the upper bound, while the latter the lower bound, and vice versa. The exact result must lie between the two bounds [27].

To sum up, we have studied a graded metal-dielectric composite lm, and found that the composition-dependent gradation in the lm yields a broad resonant plasmon band in the optical region. Thus, it is possible to gain a large nonlinearity enhancement as well as optimal FOM for graded metal-dielectric composite lms.

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FIGURES

FIG. 1. (a) Linear optical absorption $\mathrm{Im}[\ (\omega)]$, (b) enhancement of the third-order optical nonlinearity $|\ (\omega)|/\ _1$, and (c) FOM (figure of merit) $|\ (\omega)|/\{\ _1\mathrm{Im}[\ (\omega)]\}$ versus the normalized incident angular frequency ω/ω_p for layer dielectric profile $p(z) = az^m$; for different a at $m = 1.0$: Solid line: $a = 0.2$; Dashed line: $a = 0.4$; Long-dashed line: $a = 0.6$; Dot-dashed line $a = 0.8$: Parameters: $/\omega_p = 0.01$ and $\ _2 = (3/2)^2$:

FIG. 2. Same as Fig.1, but for different m at $a = 0.8$. Solid line: $m = 0.2$; Dotted line: $m = 0.6$; Dashed line: $m = 1.0$; Long-dashed line: $m = 1.4$; Dot-dashed line $m = 1.8$:

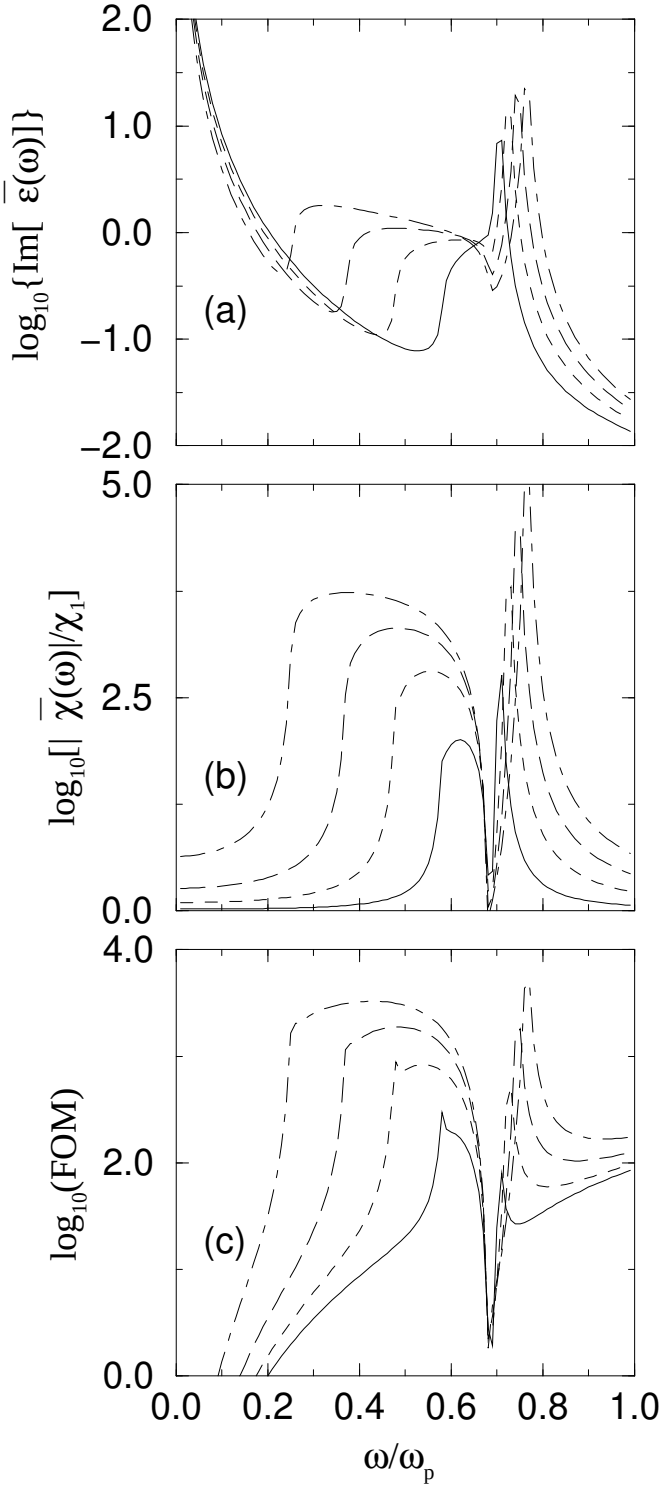

Fig. 1./Huang,Dong,Yu

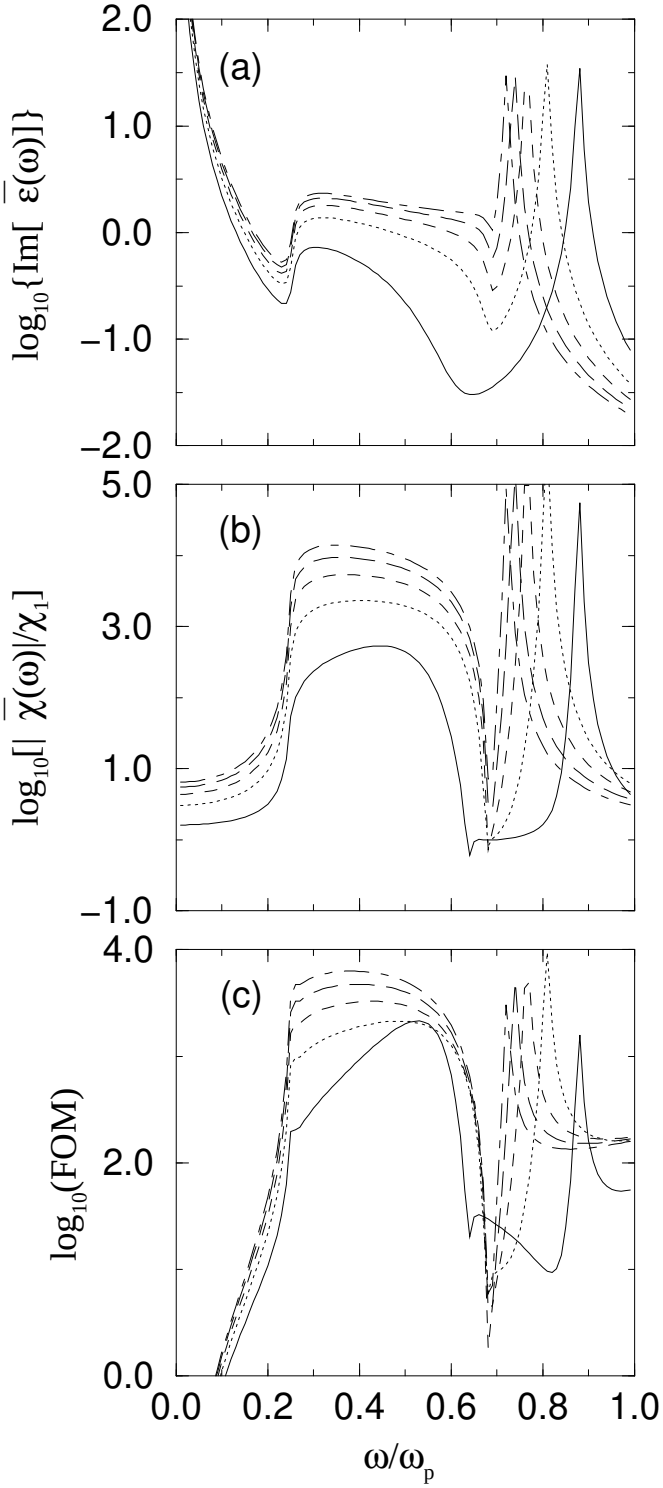

Fig. 2./Huang,Dong,Yu